查询DMC80C494 PMC 80€49 LIPCB打样工厂

, 24小时加急出货

CMOS SINGLE-COMPONENT 8-BIT MICROCOMPUTER

☐ FEATURES

- O Pin-to-pin compatible with intel's 80C48/80C35/80C49/80C39
- O 80C48/80C49 Low power mask programmable ROM.
- 80C35/80C39 Low power, CPU only.
- 1.36 μsec instruction cycle.
 All instruction 1 or 2 cycles.
- Ability to maintain operation during AC power line interruptions.
- O Exit idle mode with an external or internal interrupt signal.
- O Battery operation.
- O 3 power consumption selections

Normal operation: 12mA @ 11MHz @5V

- idle mode

: 4.8mA @ 11mHz @5V

- Power down : 2μA @2V

- O 80C49 is also available as a standard cell.
- 11MHz operation @5V±10%

MAXIMUM RATINGS

O Ambient temperature under bias

O Storage temperature

Voltage on any pin with respect to ground

Maximum voltage on any pin with respect to ground

Power dissipation

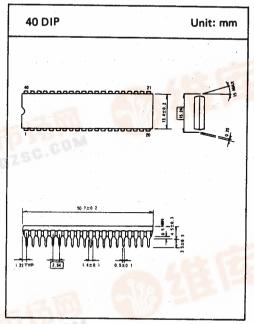
:0℃~+70℃

: -65°C ~ + 150°C

: -0.5V~V_{cc}+1V

: 7V

: 1.5 Watt.





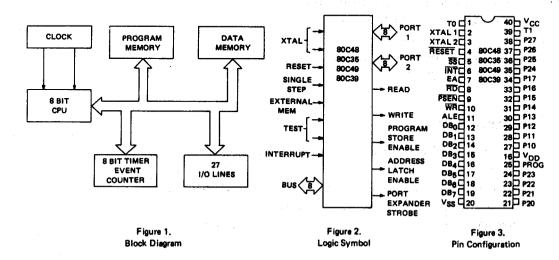
BLOCK DIAGRAM AND DESCRIPTION

DAEWOO ZyMOS TECHNOLOGY' 80C48/80C35/80C49/80C39 are low power, CHMOS version of the popular MCS-48 HMOS family members. CHMOS is a technology built on HMOS II and features high resistivity P substrate, diffused N well, and scaled N and P channel devices. The 80C48/80C35/80C49/80C39 have been designed to provide low power consumption and high performance.

The 80C48/80C49 contains a 1Kx8/2Kx8 program memory, a 64x8/128x8 RAM data memory, 27 I/O lines, and an 8bit timer/counter in addition to on-board oscillator and clock circuits. The 80C35/80C39 is the equivalent of the 80C48/80C49 without program memory on-board.

The CMOS design of the 80C48/80C49 opens new application areas that require battery operation, low power standby, wide voltage range, and the ability to maintain operation during AC power line interruptions.

These applications include portable and hand-held instruments, telecommunication consumer and automotive.



PIN DESCRIPTION

Symbol	Pin No.	Function
Vss	20	Circuit GND potential
V_{DD}	26	Low Power standby pin
V _{cc}	40	Main power supply; +5V dur-
		ing operation
PROG	25	Output strobe for 82C43 I/O
		expander
P10-P17	27-34	8-bit quasi-bidirectional port
Port 1		
	21-24	
P24-P27	35-38	P20-P23 contain the four high
Port 2		order program counter bits
		during an external program
		memory fetch and serve as a
		4-bit I/O expander bus for
and the state of	33 50 0	8243.
DB0-DB7	12-19	True bidirectional port which
BUS	, ,	can be written or read
Mark De Mark		synchronously using the RD,
institution of	*	WR strobes. The port can also
		be statically latched.
		Contains the 8 low order pro-
		gram counter bits during an
ti Bugan		external program memory
August 1.		fetch, and receives the
		addressed instruction under
		the control of PSEN. Also con-
1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		tains the address and data dur-
e e e e e e e e e e e e e e e e e e e	, Vm € .	ing an external RAM data
		store instruction, under control
ge en		of ALE, RD, and WR.
T0	1	Input pin testable using the
		conditional transfer instruc-
1. 1. 2. 3		tions JT0 and JNT0. T0 can be
		designated as a clock output
÷		using ENTO CLK instuction.
	I	

	I	
Symbol	Pin No.	Function
T1	39	Input pin testable using the
		JT1, and JNT1 instructions.
. •		Can be designated the timer/
		counter input using the STRT
- <u>-</u>		CNT instruction.
INT	6	Interrupt input. Initiates an in-
	. *	terrupt if interrupt is enabled.
		Interrupt is disabled after a
		reset. Also testable with condi-
		tional jump instruction.(Active
		low)
		Interrupt must remain low for
		at least 3 machine cycles for
		proper operation.
RD	8	Output strobe activated during
		a BUS read. Can be used to
		enable data onto toe bus from
		an external device.
		Used as a read strobe to ex-
		ternal data memory.
		(Active low)
RESET	4	Input which is used to initialize
		the processor.
. •		(Active low) (Non TTL V _{IH})
WR	10	Ouput strobe during a bus
		write.(Active low)
1 4		Used as write strobe to exter-
ALE	11	nal data memory.
ALE		Address latch enable. This sig-
		nal occurs once during each
:		cycle and is useful as a clock
		output.
		The negative edge of ALE
	4	strobes address into external
		data and program memory.

output occurs only during

PSEN

PIN DESCRIPTION(Continued)

Symbol	Pin No.	Function	
PSEN		a fetch to external program	
(Con't)		memory.(Actibe low)	
SS	5	Single step input can be used in conjunction with ALE to "single step" the processor through each instruction. (Active low)	
EA	7	External access input which forces all program memory fetches to reference external	

Symbol	Pin No.	Function		
		memory. Useful for emulation		
		and debug, and essential for		
		testing and program verifica-		
		tion.(Active high)		
XTAL1	2	One side of crystal input for in-		
		ternal oscillator. Also input for		
		external source.		
		(Non TTL VIH)		
XTAL2	3	Other side of crystal input.		

IDLE MODE DESCRIPTION

The 80C48/80C35/80C49/80C39, when placed in idle mode, keeps the oscillator, the internal timer and the external interrupt and counter pins functioning, and maintains the internal register and RAM status.

To place the 80C48/80C35/80C49/80C39 in idle mode, a command instruction(op code 01H) is executed. To terminate idle mode, a reset must be performed or interrupts must be enabled and an interrupt signal generated.

There are two interrupt sources that can restore normal operation.

One is an external signal applied to the interrupt pin. The other is form the overflow of the timer/counter. When either interrupt is invoked, the CPU is taken out of Idle mode and vectors to the interrupt's service routine address.

Along with the idle mode, the standard MCS-48 power-down mode is still maintained. During normal operation, V_{CC} serves as the 5V supply pin for the bulk of the circuitry while the V_{DD} pin supplies only the RAM array.

In normal operation both V_{CC} and V_{DD} are at 5V. However, for power-down operation, V_{CC} is at ground and V_{DD} is reduced to its standby value.

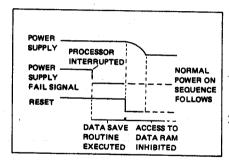
To be certain that RAM is not inadvertently accessed and altered during power down, reset should be applied to the processor until V_{cc} is at ground level.

POWER DOWN MODE DESCRIPTION

Extra circuitry has been added to the 80C48/80C49 ROM version to allow power to be removed from all but the data RAM array for low power standby operation. In the power down mode the contents of data RAM can be maintained while drawing typically 10% to 15% of normal operating power requirements.

 V_{cc} serves as the 5V supply pin for the bulk of circuitry while the V_{DD} pin supplies only the RAM array. In normal operation both pins are a 5V while in standby, V_{cc} is at ground and V_{DD} is maintained at its standby value. Applying Reset to the processor through the \overline{RESET} pin inhibits any access to the RAM by the processor and guarantees that RAM cannot be inadvertently altered as power is removed from V_{CC} .

A typical power down sequence occurs as follows:



- Imminent power supply failure is detected by user defined circuitry.
 - Signal must be early enough to allow 80C48 to save all necessary data before $V_{\rm CC}$ falls below normal operating limits.
- Power fail signal is used to interrupt processor and vector it to a power fail service routine.
- 3) Power fail routine saves all important data and machine status in the internal data RAM array. Routine may also initiate transfer of backup supply to the V_{DD} pin and indicate to external circuitry that power fail routine is complete.
- 4) Reset is applied to guarantee data will not be altered as the power supply falls out of limits.

Reset must be held how until Vcc is at ground level.

☐ INSTRUCTION SET

Accumulator			
Mnemonic	Description	Bytes	Cycles
ADD A, R	Add register to A	, 1	1
ADD A, @R	Add data memory to A	1	1
ADD A, #data	Add immediate to A	2	2
ADDC A, R	Add register with carry	1	1
ADDC A, @R	Add data memory	1	1 .
	with carry		
ADDC A, #data	Add immediate with	2	2
	carry		
ANL A, R	And register to A	1	1
ANL A, @R	And data memory to A	1	1
ANL A, # data	And immediate to A	2	2
ORL A, R	Or register to A	1	1
ORL A, @R	Or data memory to A	1	1
ORLA,# data	Or immediate to A	2 .	2
XRL A, R	Exclusive or register	1	1
	to A		
XRL A, @R	Exclusive or data	1	1
	memory to A		
XRL. A, # data	Exclusive or	2	. 2
	immediate to A		
INC A	Increment A	1	1
DEC A	Decrement A	1	1
CLR A	Clear A	1	1
CPL A	Complement A	1	1
DA A	Decimal adjust A	1	1
SWAP A	Swap nibbles of A	1	1
RLA	Rotate A left	1	1
RLC A	Rotate A left	1	1
	through carry		
RR A	Rotate A right	1	1
RRC A	Rotate A right	1	1
	through carry		

Input/Output				
Mnemonic	Description	Bytes	Cycles	
IN A, P	Input port to A	1	2	
OUTL P, A	Output A to port	1	2	
ANL P, # data	And immediate to port	2	2	
ORL P, # data	Or immediate to port	2	2	
INS A, BUS	Input BUS to A	1	2	
OUTL BUS, A	Output A to BUS	1	2	
ANL BUS,	And immediate to	2	2	
# data	RUS			

Mnemonic	Description	Bytes	Cycle
ORL BUS, # dats	Or immediate to BUS	2,	2
MOVD A, P	Input expender-port to A	1	2
MOVD P, A	Output A to expander port	- 1	2
ANLD P, A	And A to expander port	1	2
ORLD P, A	Or A to expander port	. 1	2

Registers			
Mnemonic	Description	Bytes	Cycle
INC R	Increment register	1	1
INC @R	Increment data	1	1
	memory		
DEC R	Decrement register	1	1

Branch			
Mnemonic	Description	Bytes	Cycle
JMP addr	Jump unconditional	2	2
JMPP @A	Jump indirect	1	2
DJNZ R, addr	Decrement register and skip	2	2
JC addr	Jump on carry = 1	2	2
JNC addr	Jump on carry = 0	2	2
JZ addr	Jump on A zero	2	2
JNZ addr	Jump on A not zero	2	2
JT0 addr	Jump on TO = 1	2	2
JNT0 addr	Jump on TO = 0	2	2
JT1 addr	Jump on T1 = 1	2	2
JNT1 addr	Jump on T1 = 0	2	2
JF0 addr	Jump on F0 = 1	2	2
JF1 addr	Jump on F1 = 1	2	2
JTF addr	Jump on timer flag	2	2

Subroutine			
Mnemonic	Description	Bytes	Cycle
CALL addr	Jump to subroutine	2	2

Jump on INT = 0

bit

Jump on accumulator

2

2

JN1 addr

JBb addr

INSTRUCTION SET (Continued)

Subroutine (C	Con't)		
Mnemonic	Description	Bytes	Cycles
RET	Return	1	2
RETR	Return and restore	1	2
	status		

Flags			
Mnemonic	Description	Bytes	Cycles
CLR C	Clear carry	1	1
CPL C	Complement carry	1	1
CLR FO	Clear flag 0	1	1
CPL F0	Complement flag 0	1	1
CLR F1	Clear flag 1	1	1
CPL F1	Complement flag 1	1	. 1

Data Moves

Mnemonic	Description	Bytes	Cycles
MOV A, R	Move register to A	1	1
MOV A, OR	Move data memory	1	1
•	to A	*	•
MOV A, # data	Move immediate to A	2	2
MOV R, A	Move A to register	1	1
MOV @R, A	Move A to data	1	1
, s	memory		
MOV R, # deta	Move immediate to	2	2
	register		
MOV @R, # data	Move immediate to	2	2
	data memory		
MOV A, PSW	Move PSW to A	1	1
MOV PSW, A	Move A to PSW	1	1
XCH A, R	Exchange A and	1	1
	register		
XCH A, @R	Exchange A and data	1	1
	memory		
XCHD A, @R	Exchange nibble of A	1	1
	and register		·
MOVX A, OR	Move external data	1	2
	memory to A		
MOVX @R, A	Move A to external	1	2
	data memory		
MOVP A, @A	Move to A from	1 .	2
	current page		
MOVP3 A, @	Move to A from page 3	1	2

Timer/Counter			
Mnemonic	Description ,	Bytes	Cycles
MOV A, T	Read timer/counter	1	1
MOV T, A	Load timer/counter	1	1 .
STRT T	Start timer	1	1
STRT CNT	Start timer	1 1	1
STOP TONT	Stop timer/counter	1	1
EN TCNTI	Enable timer/counter interrupt	1	1
DIS TONTI	Disable timer/counter	1	1.
	interrupt		

Control			
Mnemonic	Description	Bytes	Cycles
EN I	Enable external	. 1	1 .
	interrupt		
DIS I	Disable external	1	1
	interrupt		
SEL RBO	Select register bank 0	1	1
SEL RB1	Select register bank 1	1	1
SEL MBO	Select memory bank 0	1	1
SEL MB1	Select memory bank 1	1	1
ENTO CLK	Enable clock output	1	1
	on TÛ		

Mnemonic	Description	Bytes	Cycles
NOP	No operation	1	1
IDL .	Select Idle Operation	1	1

ELECTRICAL CHARACTERISTICS(D.C)

 $(T_A=0\sim70^{\circ}C, V_{CC}=V_{DD}=5V\pm10\%, IV_{CC}-V_{DD}I\leq1V, V_{SS}=0V$

Symbol	Parameter	Limits			11.2		
		Min.	Тур.	Max.	Unit	Test Conditions	
V _{IL}	Input Low Voltage	-0.5		0.18V _{cc}	V		
	(All Except X1, RESET)					+	
V _{ILI}	Input Low Voltage X1, RESET	-5		0.13V _{cc}	٧		
V _{IH}	Input High Voltage	2		V _{cc}	V		
	(All Except XTAL1, RESET)						
Viiii	Input High Voltage(X1, RESET)	0.7V _∞		Vα	٧		
V _{OL}	Output Low Voltage(BUS)			0.45	٧	I _{OL} =2mA	
V _{OL1}	Output Low Voltage			0.45	٧	I _{OL} = 1.8mA	
	(RD, WR, PSEN, ALE)						
V _{OL2}	Output Low Voltage(PROG)			0.45	٧	I _{OL} = 1mA	
V _{OL3}	Output Low Voltage			0.45	V	I _{oL} = 1.6mA	
	(All Other Outputs)						
V _{OH}	Output High Voltage(BUS)	0.75∨ _{cc}			V	$I_{OH} = -400 \mu A$	
V _{он}	Output High Voltage	2.4			V	$I_{OH} = -20\mu A$	
	(RD, WR, PSEN, ALE)					,	
V _{OH2}	Output High Voltage	0.75V _{cc}			ı V	$I_{OH} = -40 \mu A$	
	(All Other Outputs)				-		
l _u	Input Leakage Current(T1, INT, EA)			±5	μА	$V_{SS} \leq V_{IN} \leq V_{CC}$	
l _{Lii}	Input Leakage Current			-500	μΑ	$V_{SS} \leq V_{IN} \leq V_{CC}$	
	(P10-P17, P20-27, SS)				4.		
Lo	Output Leakage Current(BUS, TO)			±5	μА	$V_{SS} \leq V_{IN} \leq V_{CC}$	
	(High Impedance State)	.					
I _{LR}	Input Leakage Current(RESET)	-20		-300	μΑ	$V_{SS} \leq V_{IN} \leq V_{CC}$	
I _{PD}	Power Down Standby Current			2	μА	V _{DD} =2V RESET	
						≤V _{II}	

Icc Active Current(mA)

Vcc	4.5∨	5V	5.5∨
1MHz	2.5	3.3	4
6MHz	5	6.8	8.5
11MHz	9	12	15

Vcc	4.5∨	5∨	5.5V
1MHz	1.7	2	2.2
6MHz	2	3	4
11MHz	3.5	4.8	6

☐ ELECTRICAL CHARACTERISTICS(A.C)

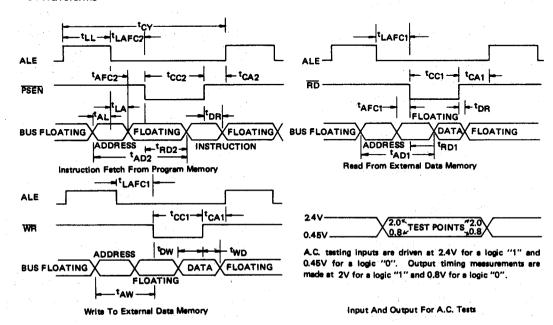
 $(T_A = 0 \sim 70^{\circ}\text{C}, \ V_{CC} = V_{DD} = 5V \pm 10\%, \ |V_{CC} - V_{DD}| \le 1V, \ V_{SS} = 0V)$

Symbol	Parameter	f(t)	11MHz		T	Conditions
		(Note 3)	Min.	Max.	Unit	(Note 1)
t	Clock Period	1/xtal freq.	90.9	1000	ns	(Note 3)
t _{LL}	ALE Pulse Width	3.5t-170	150		ns	
t _{AL}	Addr Setup to ALE	2t-110	70		ns	(Note 2)
t _{LA}	Addr Hold from ALE	t-40	50		ns	
t _{CC1}	Control Pulse Width(RD, WR)	7.5t-200	480		ns	
t _{CC2}	Control Pulse Width(PSEN)	6t-200	350		ns	
t _{DW}	DAta Setup before WR	6.5t-200	390		ns	
t _{wD}	Data Hold after WR	t-50	40		ns	
t _{DR}	Data Hold(RD, PSEN)	1.5t-30	0	110	ns	
t _{RD1}	RD to Data in	6t-170		350	ns	
t _{RD2}	PSEN to Data in	4.5t-170		190	ns	
t _{AŴ}	Addr Setup to WR	5t-150	300		ns	
t _{AD1}	Addr Setup to Data(RD)	10.5t-220		730	ns	
t _{AD2}	Addr Setup to Data(PSEN)	7.5t-220		460	ns	
t _{AFC1}	Addr Float to RD, WR	2t-40	140		ns	(Note 2)
t _{AFC2}	Addr Float to PSEN	0.5t-40	10		ns	(Note 2)
t _{LAFC1}	ALE to Control(RD, WR)	3t-75	200		ns	
t _{LAFC2}	ALE to Control(PSEN)	1.5t-75	60		ns	
t _{CAI}	Control to ALE(RD, WR, PROG)	t-40	50		ns	
t _{CA2}	Control to ALE(PSEN)	4t-40	320		ns	
t _{CP}	Port Control Setup to PROG	1.5t-80	50		ns	
t _{PC}	Port Control Hold to PROG	4t-260	100		ns	
t _{PR}	PROG to P2 Input Valid	8.5t-120		650	ns	
t _{PF}	Input Data Hold from PROG	1.5t	0	140	ns	
t _{DP}	Output Data Setup	6t-290	250		ns	
t _{PD}	Output Data Hold	1.5t-90	40		ns	
t _{PP}	PROG Pulse Width	10.5t-250	700		ns	
t _{PL}	Port 2 I/O Setup to ALE	4t-200	160		ns	
t LP	Port 2 I/O Hold to ALE	1.5t-120	15		ns	
t _{PV}	Port Output from ALE	4.5t + 100		510	ns	
t _{OPRR}	T0 Rep Rate	3t	270		ns	
t _{CY}	Cycle Time	15t	1.36	15	μS	

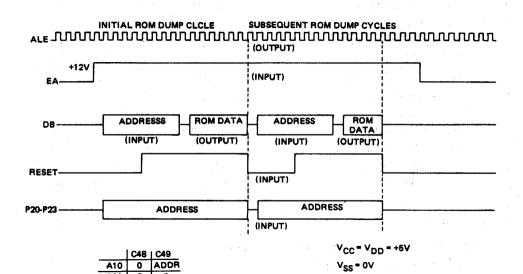
- Note : 1. Control output $C_L = 80 pF$, Bus outputs $C_L = 150 pF$
 - 2. Bus high impedance Load 20pf
 - 3. f(t) assumes 50% duty cycle on X1, X2 Max. clock period is for a 1MHz crystal input.

TIMING DIAGRAM

Waveforms

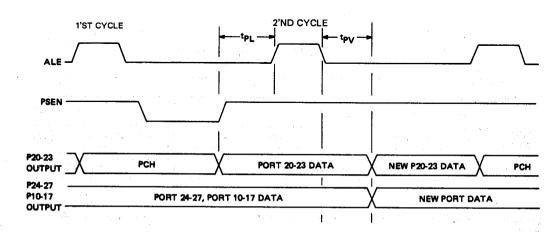


Suggested ROM verification algorithm for CMOS devices only

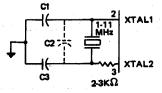


☐ TIMING DIAGRAM(Continued)

○ I/O Port timing



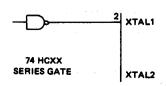
OSCILLATOR MODE



C1 = $20pF \pm 2pF - STRAY < 5pF$ C2 = CRYSTAL - STRAY < 8pFC3 = $20pF \pm 2pF - STRAY < 5pF$

Crystal series resistance should be less than 30Ω at 11 MHz; less than 75Ω at 6 MHz; less than 180Ω at 3.6 MHz.

DRIVING FROM EXTERNAL SOURCE



XTAL1 must be high 35-65% of the period.

Rise and fall times must not be slower than 20 nS.

TIMING DIAGRAM(Continued)

O Port 1/Port 2 timing

